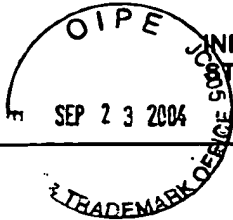


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PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.  
ELM/002 Cont. 4APPLN. NO.  
10/672,961APPLICANTS  
Glenn J. LeedyCONF. NO.  
9439FILING DATE  
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2811INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT

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| EXAMINER<br>INITIAL | DOCUMENT<br>NUMBER | DATE     | NAME               | CLASS | SUBCLASS | FILING DATE<br>IF<br>APPROPRIATE |
|---------------------|--------------------|----------|--------------------|-------|----------|----------------------------------|
| ml                  | 2,915,722          | 12/01/59 | Foster             | 336   | 115      |                                  |
|                     | 3,202,948          | 08/24/65 | Farrand            | 336   | 115      |                                  |
|                     | 3,559,282          | 02/02/71 | Lesk               | 438   | 113      |                                  |
|                     | 3,560,364          | 02/02/71 | Burkhardt          | 324   | 207.12   |                                  |
|                     | 3,602,982          | 09/07/71 | Emmasingel         | 29    | 577      |                                  |
|                     | 3,615,901          | 10/26/71 | Medicus            | 148   | 11.5 R   |                                  |
|                     | 3,716,429          | 02/13/73 | Napoli et al.      | 156   | 17       |                                  |
|                     | 3,777,227          | 12/14/73 | Krishna et al.     | 257   | 578      |                                  |
|                     | 3,868,565          | 02/25/75 | Kuipers            | 324   | 207.26   |                                  |
|                     | 3,922,705          | 11/25/75 | Yerman             | 357   | 26       |                                  |
|                     | 3,997,381          | 12/14/76 | Wanlass            | 156   | 3        |                                  |
|                     | 4,070,230          | 01/24/78 | Stein              | 156   | 657      |                                  |
|                     | 4,131,985          | 01/02/79 | Greenwood et al.   | 29    | 580      |                                  |
|                     | 4,142,004          | 02/27/79 | Hauser, Jr. et al. | 438   | 792      |                                  |
|                     | 4,251,909          | 02/24/81 | Hoeberechts        | 29    | 580      |                                  |
|                     | 4,262,631          | 04/21/81 | Kubacki            | 118   | 723MP    |                                  |
|                     | 4,394,401          | 07/19/83 | Shioya et al.      | 427   | 574      |                                  |
|                     | 4,401,986          | 08/30/83 | Trenkler et al.    | 340   | 870.32   |                                  |
|                     | 4,416,054          | 11/22/83 | Thomas et al.      | 29    | 572      |                                  |
|                     | 4,500,905          | 02/19/85 | Shibata            | 357   | 68       |                                  |
|                     | 4,539,068          | 09/03/85 | Takagi et al.      | 156   | 614      |                                  |
|                     | 4,585,991          | 04/29/86 | Reid et al.        | 324   | 158 P    |                                  |
|                     | 4,612,083          | 09/16/86 | Yasumoto et al.    | 156   | 633      |                                  |
|                     | 4,617,160          | 10/14/86 | Belanger et al.    | 264   | 40.1     |                                  |
|                     | 4,618,397          | 10/21/86 | Shimizu et al.     | 156   | 628      |                                  |
|                     | 4,618,763          | 10/21/86 | Schmitz            | 250   | 211R     |                                  |
| ml                  | 4,663,559          | 05/05/87 | Christensen        | 313   | 336      |                                  |

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|   | APPLICANTS<br>Glenn J. Leedy        | CONF. NO.<br>9439        |
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|---------------------|--------------------|----------|----------------|-------|----------|----------------------------------|
| ML                  | 4,684,436          | 08/04/87 | Burns et al.   | 216   | 65       |                                  |
|                     | 4,693,770          | 09/15/87 | Hatada         | 156   | 151      |                                  |
|                     | 4,702,336          | 10/27/87 | Maeda et al.   | 180   | 197      |                                  |
|                     | 4,702,936          | 10/27/87 | Seibert et al. | 427   | 583      |                                  |
|                     | 4,706,166          | 11/10/87 | Go             | 361   | 403      |                                  |
|                     | 4,721,938          | 01/26/88 | Stevenson      | 338   | 4        |                                  |
|                     | 4,761,681          | 08/02/88 | Reid           | 357   | 68       |                                  |
|                     | 4,784,721          | 11/15/88 | Holmen et al.  | 156   | 647      |                                  |
|                     | 4,810,673          | 03/07/89 | Freeman        | 438   | 386      |                                  |
|                     | 4,825,277          | 04/25/89 | Mattox et al.  | 257   | 639      |                                  |
|                     | 4,857,481          | 08/15/89 | Tam et al.     | 438   | 619      |                                  |
|                     | 4,892,753          | 01/09/90 | Wang, et al.   | 427   | 579      |                                  |
|                     | 4,897,708          | 01/30/90 | Clements       | 257   | 690      |                                  |
|                     | 4,924,589          | 05/15/90 | Leedy          | 438   | 6        |                                  |
|                     | 4,939,568          | 07/03/90 | Kato, et al.   | 357   | 75       |                                  |
| ML                  | 4,940,916          | 07/10/90 | Borel et al.   | 313   | 306      |                                  |
|                     | Re B14,940,916     | 11/26/90 | Borel et al.   | 315   | 306      |                                  |
| ML                  | 4,950,987          | 08/21/90 | Vranish et al. | 324   | 207.23   |                                  |
|                     | 4,952,446          | 08/18/90 | Lee et al.     | 428   | 220      |                                  |
|                     | 4,954,865          | 09/04/90 | Rokos          | 257   | 378      |                                  |
|                     | 4,957,882          | 09/18/90 | Shinomiya      | 438   | 65       |                                  |
|                     | 4,965,415          | 10/23/90 | Young et al.   | 200   | 83 N     |                                  |
|                     | 4,966,663          | 10/30/90 | Mauger         | 205   | 656      |                                  |
|                     | 4,983,251          | 01/08/91 | Haisma et al.  | 438   | 3        |                                  |
|                     | 4,994,735          | 02/19/91 | Leedy          | 324   | 158      |                                  |
|                     | 5,000,113          | 03/19/91 | Wang, et al.   | 118   | 723      |                                  |
|                     | 5,008,619          | 04/16/91 | Keogh et al.   | 324   | 207.17   |                                  |
| ML                  | 5,010,024          | 04/23/91 | Allen et al.   | 438   | 659      |                                  |

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|---------------------|--------------------|----------|---------------------|-------|----------|----------------------------------|
| ML                  | 5,020,219          | 06/04/91 | Leedy               | 29    | 846      |                                  |
|                     | 5,034,685          | 07/23/91 | Leedy               | 324   | 158 F    |                                  |
|                     | 5,070,026          | 12/03/91 | Greenwald et al.    | 437   | 3        |                                  |
|                     | 5,071,510          | 12/10/91 | Findler et al.      | 156   | 647      |                                  |
|                     | 5,098,865          | 03/24/92 | Machado et al.      | 438   | 788      |                                  |
|                     | 5,103,557          | 04/14/92 | Leedy               | 29    | 832      |                                  |
|                     | 5,110,373          | 05/05/92 | Mauger              | 148   | 33.2     |                                  |
|                     | 5,111,278          | 05/05/92 | Eichelberger        | 357   | 75       |                                  |
|                     | 5,116,777          | 05/26/92 | Chan et al.         | 438   | 234      |                                  |
|                     | 5,130,894          | 07/14/92 | Miller              | 361   | 393      |                                  |
|                     | 5,132,244          | 07/21/92 | Roy                 | 438   | 477      |                                  |
|                     | 5,151,775          | 09/29/92 | Hadwin              | 357   | 80       |                                  |
|                     | 5,156,909          | 10/20/92 | Henager, Jr. et al. | 428   | 334      |                                  |
|                     | 5,203,731          | 04/20/93 | Zimmerman           | 445   | 24       |                                  |
|                     | 5,225,771          | 07/06/93 | Leedy               | 324   | 158      |                                  |
|                     | 5,236,118          | 08/17/93 | Bower et al.        | 228   | 193      |                                  |
|                     | 5,240,458          | 08/31/93 | Linglain, et al.    | 464   | 63       |                                  |
|                     | 5,259,247          | 11/09/93 | Bantien             | 73    | 718      |                                  |
|                     | 5,262,351          | 11/16/93 | Bureau et al.       | 437   | 183      |                                  |
|                     | 5,270,261          | 12/14/93 | Bertin et al.       | 437   | 209      |                                  |
|                     | 5,273,940          | 12/28/93 | Sanders             | 437   | 209      |                                  |
|                     | 5,274,270          | 12/28/93 | Tuckerman           | 257   | 758      |                                  |
|                     | 5,279,865          | 01/18/94 | Chebi et al.        | 427   | 574      |                                  |
|                     | 5,284,796          | 02/08/94 | Nakanishi et al.    | 437   | 183      |                                  |
|                     | 5,323,035          | 06/21/94 | Leedy               | 257   | 48       |                                  |
|                     | 5,324,687          | 06/28/94 | Wojnarowski         | 437   | 225      |                                  |
| ML                  | 5,354,695          | 10/11/94 | Leedy               | 438   | 411      |                                  |

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|---------------------|--------------------|----------|-------------------|-------|----------|----------------------------------|
| Mc                  | 5,363,021          | 11/08/94 | MacDonald         | 315   | 366      |                                  |
|                     | 5,385,632          | 01/31/95 | Goossen           | 156   | 630      |                                  |
|                     | 5,385,909          | 01/31/95 | Nelson et al.     | 514   | 291      |                                  |
|                     | RE 34,893          | 04/04/95 | Fujii et al.      | 257   | 419      |                                  |
|                     | 5,420,458          | 05/30/95 | Shimoji           | 257   | 622      |                                  |
|                     | 5,424,920          | 06/13/95 | Miyake            | 361   | 735      |                                  |
|                     | 5,426,072          | 06/20/95 | Finnila           | 437   | 208      |                                  |
|                     | 5,426,363          | 06/20/95 | Akagi et al.      | 324   | 239      |                                  |
|                     | 5,432,444          | 07/11/95 | Yasohama et al.   | 324   | 240      |                                  |
|                     | 5,432,729          | 07/11/95 | Carson et al.     | 365   | 63       |                                  |
|                     | 5,434,500          | 07/18/95 | Hauck et al.      | 324   | 67       |                                  |
|                     | 5,451,489          | 09/19/95 | Leedy             | 430   | 313      |                                  |
|                     | 5,453,404          | 09/26/95 | Leedy             | 437   | 203      |                                  |
|                     | 5,457,879          | 10/17/95 | Gurtler et al.    | 29    | 895      |                                  |
|                     | 5,476,813          | 12/19/95 | Naruse            | 437   | 132      |                                  |
|                     | 5,489,554          | 02/06/96 | Gates             | 437   | 208      |                                  |
|                     | 5,502,667          | 03/26/96 | Bertin et al.     | 365   | 51       |                                  |
|                     | 5,512,397          | 04/30/96 | Leedy             | 430   | 30       |                                  |
|                     | 5,527,645          | 06/18/96 | Pati et al.       | 430   | 5        |                                  |
|                     | 5,529,829          | 06/25/96 | Koskenmaki et al. | 428   | 167      |                                  |
|                     | 5,534,465          | 07/09/96 | Frye et al.       | 437   | 209      |                                  |
|                     | 5,555,212          | 09/10/96 | Toshiaki et al.   | 365   | 200      |                                  |
|                     | 5,563,084          | 10/08/96 | Ramm et al.       | 437   | 51       |                                  |
|                     | 5,571,741          | 11/05/96 | Leedy             | 437   | 51       |                                  |
|                     | 5,580,687          | 12/03/96 | Leedy             | 430   | 5        |                                  |
|                     | 5,581,498          | 12/03/96 | Ludwig et al.     | 365   | 63       |                                  |
|                     | 5,582,939          | 12/10/96 | Pierrat           | 430   | 5        |                                  |

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|---------------------|--------------------|----------|-----------------|-------|----------|----------------------------------|
| MC                  | 5,583,688          | 12/10/96 | Hornbeck        | 359   | 291      |                                  |
|                     | 5,592,007          | 01/07/97 | Leedy           | 257   | 347      |                                  |
|                     | 5,592,018          | 01/07/97 | Leedy           | 257   | 619      |                                  |
|                     | 5,595,933          | 01/21/97 | Heijboer        | 439   | 20       |                                  |
|                     | 5,606,186          | 02/25/97 | Noda            | 257   | 226      |                                  |
|                     | 5,627,112          | 05/06/97 | Tennant et al.  | 438   | 113      |                                  |
|                     | 5,629,137          | 05/13/97 | Leedy           | 430   | 313      |                                  |
|                     | 5,633,209          | 05/27/97 | Leedy           | 435   | 228      |                                  |
|                     | 5,637,536          | 06/10/97 | Val             | 438   | 686      |                                  |
|                     | 5,654,127          | 08/05/97 | Leedy           | 430   | 315      |                                  |
|                     | 5,654,220          | 08/05/97 | Leedy           | 438   | 25       |                                  |
|                     | 5,656,552          | 08/12/97 | Hudak et al.    | 438   | 15       |                                  |
|                     | 5,675,185          | 10/07/97 | Chen et al.     | 257   | 774      |                                  |
|                     | 5,694,588          | 12/02/97 | Ohara et al.    | 395   | 566      |                                  |
|                     | 5,725,995          | 03/10/98 | Leedy           | 430   | 315      |                                  |
|                     | 5,750,211          | 05/12/98 | Weise et al.    | 427   | 579      |                                  |
|                     | 5,760,478          | 06/02/98 | Bozso et al.    | 257   | 777      |                                  |
|                     | 5,773,152          | 06/30/98 | Okonogi         | 428   | 446      |                                  |
|                     | 5,786,116          | 07/28/98 | Rolfson         | 430   | 5        |                                  |
|                     | 5,793,115          | 08/11/98 | Zavracky et al. | 257   | 777      |                                  |
|                     | 5,831,280          | 11/03/98 | Ray             | 257   | 48       |                                  |
|                     | 5,834,334          | 11/10/98 | Leedy           | 438   | 107      |                                  |
|                     | 5,840,593          | 11/24/98 | Leedy           | 438   | 6        |                                  |
|                     | 5,856,695          | 01/05/99 | Ito et al.      | 257   | 370      |                                  |
|                     | 5,868,949          | 02/09/99 | Sotokawa et al. | 216   | 18       |                                  |
|                     | 5,869,354          | 02/09/99 | Leedy           | 438   | 110      |                                  |
|                     | 5,870,176          | 02/09/99 | Sweatt et al.   | 355   | 53       |                                  |
|                     | 5,880,010          | 03/09/99 | Davidson        | 438   | 455      |                                  |

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|---------------------|--------------------|----------|----------------|-------|----------|----------------------------------|
| WLC                 | 5,882,532          | 03/16/99 | Field et al.   | 216   | 2        |                                  |
|                     | 5,902,118          | 05/11/99 | Hübner         | 438   | 106      |                                  |
|                     | 5,915,167          | 06/22/99 | Leedy          | 438   | 108      |                                  |
|                     | 5,946,559          | 08/31/99 | Leedy          | 438   | 157      |                                  |
|                     | 5,985,693          | 11/16/99 | Leedy          | 438   | 107      |                                  |
|                     | 5,998,069          | 12/07/99 | Cutter et al.  | 430   | 5        |                                  |
|                     | 6,008,126          | 12/28/99 | Leedy          | 438   | 667      |                                  |
|                     | 6,020,257          | 02/01/00 | Leedy          | 438   | 626      |                                  |
|                     | RE 36,623          | 03/21/00 | Wang, et al.   | 427   | 579      |                                  |
|                     | 6,045,625          | 04/04/00 | Houston        | 148   | 33.3     |                                  |
|                     | 6,084,284          | 07/04/00 | Adamic, Jr.    | 257   | 506      |                                  |
|                     | 6,087,284          | 07/11/00 | Brix, et al.   | 501   | 69       |                                  |
|                     | 6,097,096          | 08/01/00 | Gardner et al. | 257   | 777      |                                  |
|                     | 6,133,640          | 10/17/00 | Leedy          | 257   | 778      |                                  |
|                     | 6,194,245 B1       | 02/27/01 | Tayanaka       | 438   | 57       |                                  |
|                     | 6,197,456 B1       | 03/06/01 | Aleshin et al. | 430   | 5        |                                  |
|                     | 6,208,545 B1       | 03/27/01 | Leedy          | 365   | 51       |                                  |
|                     | 6,236,602 B1       | 05/22/01 | Patti          | 365   | 201      |                                  |
|                     | 6,261,728 B1       | 07/17/01 | Lin            | 430   | 30       |                                  |
|                     | 6,288,561 B1       | 09/11/01 | Leedy          | 324   | 760      |                                  |
|                     | 6,294,909 B1       | 09/25/01 | Leedy          | 324   | 207.17   |                                  |
|                     | 6,518,073          | 02/11/03 | Momohara       | 438   | 4        | 12/10/2001                       |

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| EXAMINER<br>INITIAL | DOCUMENT<br>NUMBER      | DATE               | COUNTRY            | CLASS | SUBCLASS | TRANSLATION |    |
|---------------------|-------------------------|--------------------|--------------------|-------|----------|-------------|----|
|                     |                         |                    |                    |       |          | YES         | NO |
|                     | <del>DE 32 33 195</del> | <del>03/1983</del> | <del>Germany</del> |       |          |             |    |
| ML                  | JP 60-74643             | 04/1985            | Japan              |       |          |             |    |
| ML                  | JP S60-126871           | 07/1985            | Japan              |       |          |             |    |

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| ML | EP 0 189 976             | 08/1986            | EPO               |  |  |  |  |
| ML | JP S63-229862            | 09/1988            | Japan             |  |  |  |  |
|    | <del>JP H01-199476</del> | <del>09/1988</del> | <del>Japan</del>  |  |  |  |  |
|    | <del>2641129</del>       | <del>12/1988</del> | <del>France</del> |  |  |  |  |
| ML | EP 0 314 437             | 05/1989            | EPO               |  |  |  |  |
| ML | GB 2,215,168             | 09/1989            | UK                |  |  |  |  |
| ML | JP 402027600A            | 01/1990            | Japan             |  |  |  |  |
| ML | JP 02-082564             | 03/1990            | Japan             |  |  |  |  |
|    | <del>JP H03-284871</del> | <del>12/1991</del> | <del>Japan</del>  |  |  |  |  |
| ML | WO 92/03848              | 03/1992            | PCT               |  |  |  |  |
| ML | JP 04-076946             | 03/1992            | Japan             |  |  |  |  |
| ML | JP 04-083371             | 03/1992            | Japan             |  |  |  |  |
| ML | JP 04-107964             | 04/1992            | Japan             |  |  |  |  |
| ML | JP 04-196263             | 07/1992            | Japan             |  |  |  |  |
| ML | EP 0 731 525             | 09/1996            | EPO               |  |  |  |  |
| ML | WO 98/19337              | 05/1998            | PCT               |  |  |  |  |
| ML | WO 01/05366              | 01/2001            | PCT               |  |  |  |  |

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|   | APPLICANTS<br>Glenn J. Leedy        | CONF. NO.<br>9439        |
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